innodisk

Total Solution For Industrial Flash Storage

SATA Slim

3SE-P Series

Customer: _____

Customer Part Number: _____

Innodisk Part Number: _____

Innodisk Model Name: _____

Date: _____

Innodisk Approver	Customer Approver

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Revision History

Revision	Description	Date
Preliminary	First Released	Nov., 2013
Rev 1.0	Update Performance	Mar., 2014
Rev 1.1	Modify TBW based on NAND Flash specifications	Jan., 2015

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1. Product Overview

1.1 Introduction of Innodisk SATA Slim 3SE-P

Innodisk SATA Slim 3SE-P is designed with standard SATA interface (7+15 SATA connector), which could support most platforms with standard SATA port. Besides, with its smaller dimension, SATA Slim 3SE-P is an alternative solution of 2.5” SSD for those embedded system that may have mechanical and space concerns. SATA Slim 3SE-P operates under SATA III (6.0Gb/s) protocol with good performance. Furthermore, SATA Slim 3SE-P support TRIM for windows 7, it can improves performance when deleting files.

SATA Slim 3SE-P is also suitable in industrial field. It effectively reduces the booting time of operation system and the power consumption is less than hard disk drive (HDD). SATA Slim 3SE-P is compatible with ATA protocol, no additional drivers are required, and the SATA Slim 3SE-P can be configured as a boot device or data storage device.

1.2 Product View and Models

Innodisk SATA Slim 3SE-P is available in follow capacities within SLC flash ICs.

SATA Slim 3SE-P 08GB
SATA Slim 3SE-P 16GB
SATA Slim 3SE-P 32GB
SATA Slim 3SE-P 64GB
SATA Slim 3SE-P 128GB

Figure 1: Innodisk SATA Slim 3SE-P

1.3 SATA Interface

SATA Slim 3SE-P supports SATA III interface, and backward compliant with Serial ATA Gen 1, Gen 2 and Gen 3 specification (Gen 3 supports 1.5Gbps /3.0Gbps/6.0Gbps data rate)..

1.4 Capacity

Innodisk SATA Slim 3SE-P provides unformatted 8GB, 16GB, 32GB, 64GB, and 128GB capacities within SLC Flash IC.

1.5 MO-297 Form Factor

SATA Slim 3SE-P has a compact design 54.0mm (W) x 39.0mm (L) x 4.0mm (H) without metal material case, and is easy for installation.

2. Product Specifications

2.1 Capacity and Device Parameters

SATA Slim 3SE-P device parameters are shown in Table 1.

Table 1: Device parameters

Capacity	LBA	Cylinders	Heads	Sectors	User Capacity(MB)
8GB	13695696	13587	16	63	6,687
16GB	29323728	16383	16	63	14,318
32GB	60579792	16383	16	63	29,580
64GB	121138416	16383	16	63	59,150
128GB	242255664	16383	16	63	118,289

2.2 Performance

Burst Transfer Rate: 6.0Gbps

Table 2: Performance

Capacity	8GB	16GB	32GB	64GB	128GB
Sequential Read (max.)	410 MB/sec	410 MB/sec	480 MB/sec	480 MB/sec	480 MB/sec
Sequential Write (max.)	110 MB/sec	130 MB/sec	230 MB/sec	330 MB/sec	330 MB/sec

Note: Base on CrystalDiskMark 3.01 with file size 1000MB

2.3 Electrical Specifications

2.3.1 Power Requirement

Table 3: Innodisk SATA Slim 3SE-P Power Requirement

Item	Symbol	Rating	Unit
Input voltage	V_{IN}	+5 DC +- 5%	V

2.3.2 Power Consumption

Table 4: Power Consumption

Mode	Power Consumption (mA)
Read	232 (max.)
Write	261 (max.)
Idle	198 (max.)

* Target: 2.5: SATA SSD 3SE-P 128GB

2.4 Environmental Specifications

2.4.1 Temperature Ranges

Table 5: Temperature range for SATA Slim 3SE-P

Temperature	Range
Operating	Standard Grade: 0°C to +70°C
	Industrial Grade:-40°C to +85°C
Storage	-55°C to +95°C

2.4.2 Humidity

Relative Humidity: 10-95%, non-condensing

2.4.3 Shock and Vibration

Table 6: Shock/Vibration Testing for SATA Slim 3SE-P

Reliability	Test Conditions	Reference Standards
Vibration	7 Hz to 2K Hz, 20G, 3 axes	IEC 68-2-6
Mechanical Shock	Duration: 0.5ms, 1500 G, 3 axes	IEC 68-2-27

2.4.4 Mean Time between Failures (MTBF)

Table 7 summarizes the MTBF prediction results for various SATA Slim 3SE-P configurations. The analysis was performed using a RAM Commander™ failure rate prediction.

- **Failure Rate**: The total number of failures within an item population, divided by the total number of life units expended by that population, during a particular measurement interval under stated condition.
- **Mean Time between Failures (MTBF)**: A basic measure of reliability for repairable items: The mean number of life units during which all parts of the item perform within their specified limits, during a particular measurement interval under stated conditions.

Table 7: 2.5” SATA SSD 3SE-P MTBF

Product	Condition	MTBF (Hours)
Innodisk SATA Slim 3SE-P	Telcordia SR-332 GB, 25°C	>3,000,000

2.5 CE and FCC Compatibility

SATA Slim 3SE-P conforms to CE and FCC requirements.

2.6 RoHS Compliance

SATA Slim 3SE-P is fully compliant with RoHS directive.

2.7 Reliability

Parameter	Value
Read Cycles	Unlimited Read Cycles
Wear-Leveling Algorithm	Support
Bad Blocks Management	Support
Error Correct Code	Support
TBW (Unit: TB)	
8GB	432 (Sequential Write)
16GB	864 (Sequential Write)
32GB	1728 (Sequential Write)
64GB	3456 (Sequential Write)
128GB	6912 (Sequential Write)

2.8 Transfer Mode

SATA Slim 3SE-P support following transfer mode:

Serial ATA III 6.0Gbps

Serial ATA II 3.0Gbps

Serial ATA I 1.5Gbps

2.9 Pin Assignment

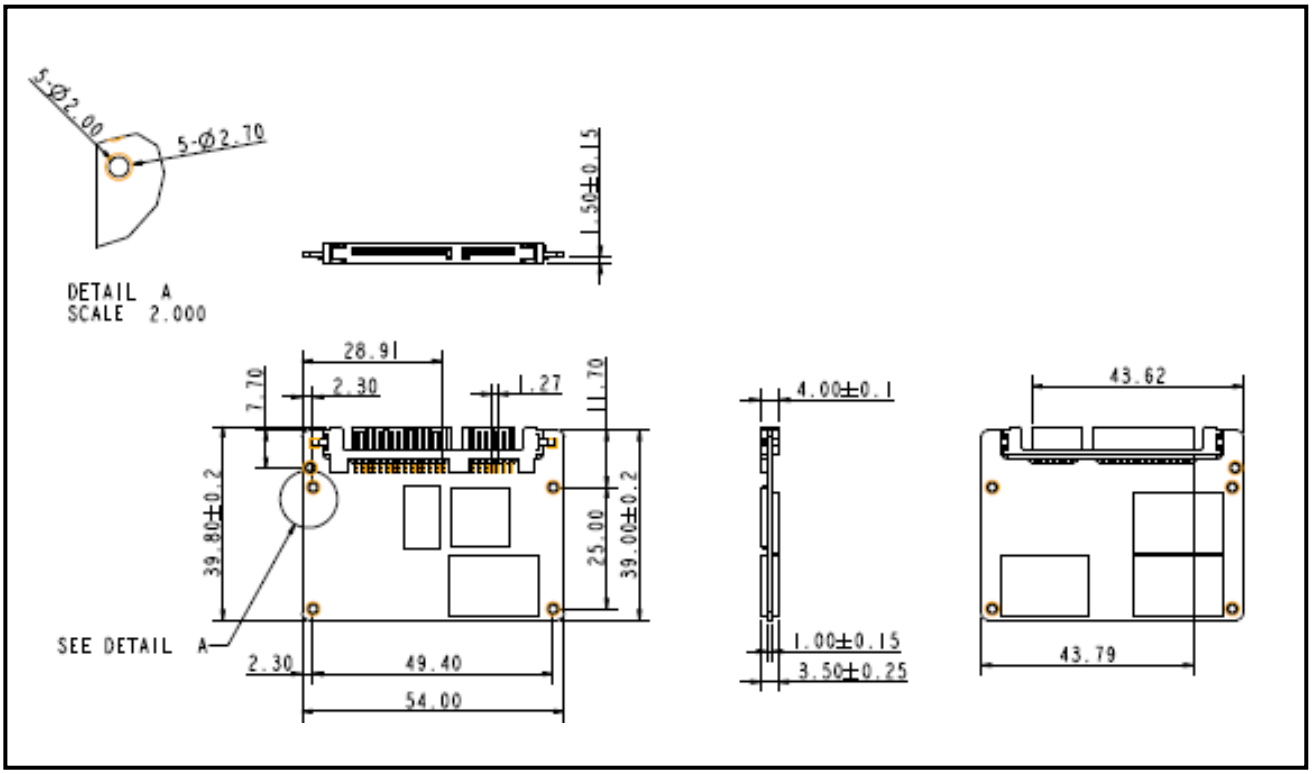
Innodisk SATA Slim 3SE-P uses a standard SATA pin-out. See Table 8 for SATA Slim 3SE-P pin assignment.

Table 8: Innodisk SATA Slim 3SE-P Pin Assignment

Name	Type	Description
S1	GND	NA
S2	A+	Differential Signal Pair A
S3	A-	
S4	GND	NA
S5	B-	Differential Signal Pair B
S6	B+	
S7	GND	NA
Key and Spacing separate signal and power segments		
P1	NC	NA

P2	NC	NA
P3	NC	NA
P4	GND	NA
P5	GND	NA
P6	GND	NA
P7	V5	5V Power, Pre-Charge
P8	V5	5V Power
P9	V5	5V Power
P10	GND	NA
P11	DAS/DSS	Device Activity Signal / Disable Staggered
P12	GND	NA
P13	NC	NA
P14	NC	NA
P15	NC	NA

2.10 Mechanical Dimensions



2.11 Assembly Weight

An Innodisk SATA Slim 3SE-P within SLC flash ICs, 32GB’s weight is 40 grams approx. The total weight of SSD will be less than 50 grams.

2.12 Seek Time

Innodisk SATA Slim 3SE-P is not a magnetic rotating design. There is no seek or rotational latency required.

2.13 Hot Plug

The SSD support hot plug function and can be removed or plugged-in during operation. User has to avoid hot plugging the SSD which is configured as boot device and installed operation system.

Surprise hot plug : The insertion of a SATA device into a backplane (combine signal and power) that has power present. The device powers up and initiates an OOB sequence.

Surprise hot removal: The removal of a SATA device from a powered backplane, without first being placed in a quiescent state.

2.14 NAND Flash Memory

Innodisk SATA Slim 3SE-P uses Single Level Cell (SLC) NAND flash memory, which is non-volatility, high reliability which has 100,000 program/erase times and high speed memory storage.

3. Theory of Operation

3.1 Overview

Figure 2 shows the operation of Innodisk SATA Slim 3SE-P from the system level, including the major hardware blocks.

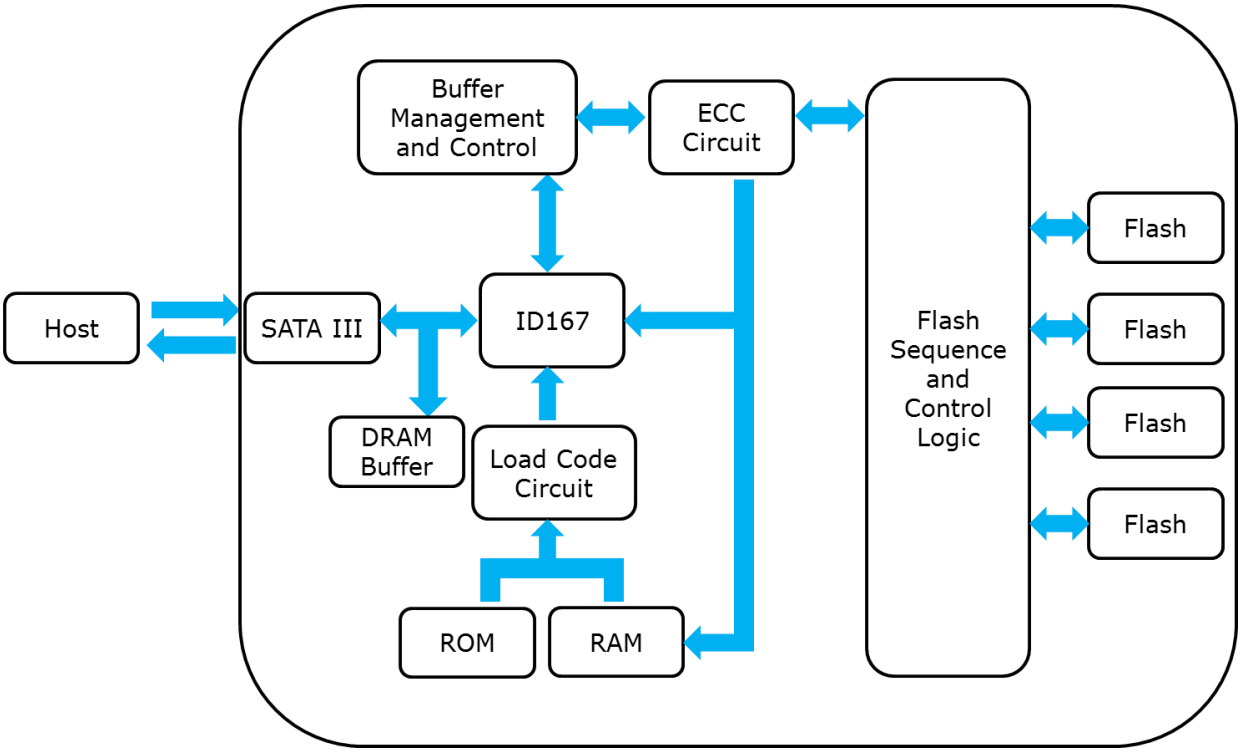


Figure 2: Innodisk SATA Slim 3SE-P Block Diagram

Innodisk 2 SATA Slim 3SE-P integrates a SATA III controller and NAND flash memories. Communication with the host occurs through the host interface, using the standard ATA protocol. Communication with the flash device(s) occurs through the flash interface.

3.2 SATA III Controller

Innodisk SATA Slim 3SE-P is designed with ID 167, a SATA III 6.0Gbps (Gen. 3) controller, which supports external DDDR3 DRAM. The Serial ATA physical, link and transport layers are compliant with Serial ATA Gen 1, Gen 2 and Gen 3 specification (Gen 3 supports 1.5Gbps/3.0Gbps/6.0Gbps data rate). The controller has 4 channels for flash interface.

3.3 Error Detection and Correction

Highly sophisticated Error Correction Code algorithms are implemented. The ECC unit consists of the Parity Unit (parity-byte generation) and the Syndrome Unit (syndrome-byte computation). This unit implements an algorithm that can correct 40 bits per 1024 bytes in an ECC block. Code-byte generation during write operations, as well as error detection during read operation, is implemented on the fly without any speed penalties.

3.4 Wear-Leveling

Flash memory can be erased within a limited number of times. This number is called the ***erase cycle limit*** or ***write endurance limit*** and is defined by the flash array vendor. The erase cycle limit applies to each individual erase block in the flash device.

Innodisk SATA Slim 3SE-P uses a static wear-leveling algorithm to ensure that consecutive writes of a specific sector are not written physically to the same page/block in the flash. This spreads flash media usage evenly across all pages, thereby extending flash lifetime.

3.5 Bad Blocks Management

Bad Blocks are blocks that contain one or more invalid bits whose reliability are not guaranteed. The Bad Blocks may be presented while the SSD is shipped, or may develop during the life time of the SSD. When the Bad Blocks is detected, it will be flagged, and not be used anymore. The SSD implement Bad Blocks management, Bad Blocks replacement, Error Correct Code to avoid data error occurred. The functions will be enabled automatically to transfer data from Bad Blocks to spare blocks, and correct error bit.

3.6 Power Cycling

Innodisk’s power cycling management is a comprehensive data protection mechanism that functions before and after a sudden power outage to SSD. Low-power detection terminates data writing before an abnormal power-off, while table-remapping after power-on deletes corrupt data and maintains data integrity. Innodisk’s power cycling provides effective power cycling management, preventing data stored in flash from degrading with use.

3.7 Garbage Collection/TRIM

Garbage collection and TRIM technology is used to maintain data consistency and perform continual data cleansing on SSDs. It runs as a background process, freeing up valuable controller resources while sorting good data into available blocks, and deleting bad blocks. It also significantly reduces write operations to the drive, thereby increasing the SSD’s speed and lifespan.

4. Installation Requirements

4.1 SATA Slim 3SE-P Pin Directions

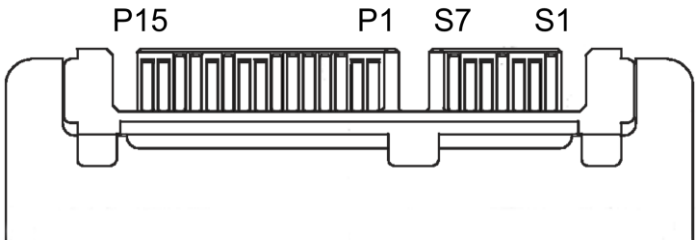


Figure 3: Signal Segment and Power Segment

4.2 Electrical Connections for SATA Slim 3SE-P

A Serial ATA device may be either directly connected to a host or connected to a host through a cable. For connection via cable, the cable should be no longer than 1meter. The SATA interface has a separate connector for the power supply. Please refer to the pin description for further details.

4.3 Device Drive

No additional device drives are required. Innodisk SATA Slim 3SE-P can be configured as a boot device.

5. Part Number Rule

CODE	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17	18	19	20
	D	**E**	**S**	**L**	**M**	**-**	**3**	**2**	**G**	**D**	**6**	**7**	**S**	**C**	**A**	**Q**	**B**	**-**	**X**	**X**
Description	Disk	SATA Slim 3SE-P					Capacity			Category			Flash Mode	Operation Temp.	Internal Control	CH.	Flash	-	Customized Code	

Definition	
Code 1st (Disk)	**Code 13th (Flash Mode)**
D : Disk	S: Synchronous flash
Code 2nd ~ 5th (Form Factor)	**Code 14th (Operation Temperature)**
GSLM: SATA Slim 3SE-P	C: Standard Grade (0℃~ +70℃)
Code 7th ~9th (Capacity)	W: Industrial Grade (-40℃~ +85℃)
08G: 8GB	**Code 15th (Internal control)**
16G: 16GB	**Code 16th (Channel of data transfer)**
32G: 32GB	D: Dual Channels
64G: 64GB	Q: Quad Channels
A28: 128GB	
Code 10th ~12th (Series)	**Code 17th (Flash Type)**
D67: ID167	B: Toshiba SLC
	Code 19th~20th (Customized Code)

Appendix

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宜鼎國際股份有限公司
Innodisk Corporation

Tel:(02)7703-3000 Fax:(02) 7703-3555 Internet: http://www.innodisk.com/

RoHS 自我宣告書(RoHS Declaration of Conformity)

Manufacturer Product: All Innodisk EM Flash and Dram products

一、 宜鼎國際股份有限公司（以下稱本公司）特此保證售予貴公司之所有產品，皆符合歐盟 2011/65/EU 關於 RoHS 之規範要求。

Innodisk Corporation declares that all products sold to the company, are complied with European Union RoHS Directive (2011/65/EU) requirement

二、 本公司同意因本保證書或與本保證書相關事宜有所爭議時，雙方宜友好協商，達成協議。

Innodisk Corporation agrees that both parties shall settle any dispute arising from or in connection with this Declaration of Conformity by friendly negotiations.

Name of hazardous substance	Limited of RoHS ppm（mg/kg）
Cd	< 100 ppm
Pb	< 1000 ppm
Hg	< 1000 ppm
Chromium VI（Cr+6）	< 1000 ppm
Polybromodiphenyl ether（PBDE）	< 1000 ppm
Polybrominated Biphenyls（PBB）	< 1000 ppm

立 保 證 書 人 (Guarantor)

Company name 公司名稱： Innodisk Corporation 宜鼎國際股份有限公司

Company Representative 公司代表人： Richard Lee 李鐘亮

Company Representative Title 公司代表人職稱： CEO 執行長

Date 日期： 2014 / 07 / 29

(Company Stamp/公司大小章)

宜鼎國際股份有限公司
Innodisk Corporation

Tel:(02)7703-3000 Fax:(02) 7703-3555 Internet: http://www.innodisk.com/

REACH Declaration of Conformity

Manufacturer Product: All Innodisk EM Flash and Dram products

1.宜鼎國際股份有限公司（以下稱本公司）特此保證此售予貴公司之產品，皆符合歐盟化學品法案(Registration , Evaluation and Authorization of Chemicals；REACH)之規定(http://www.echa.europa.eu/de/candidate-list-table **last updated: 16/06/2014**)。所提供之產品包含：(1) 產品或產品所使用到的所有原物料；(2)包裝材料；(3)設計、生產及重工過程中所使用到的所有原物料。

We Innodisk Corporation hereby declare that our products are in compliance with the requirements according to the REACH Regulation (http://www.echa.europa.eu/de/candidate-list-table **last updated: 16/06/2014**). Products include： 1) Product and raw material used by the product； 2) Packaging material ；3) Raw material used in the process of design, production and rework

2.本公司同意因本保證書或與本保證書相關事宜有所爭議時，雙方宜友好協商，達成協議。

InnoDisk Corporation agrees that both parties shall settle any dispute arising from or in connection with this Declaration of Conformity by friendly negotiations.

立 保 證 書 人 (Guarantor)

Company name 公司名稱： InnoDisk Corporation 宜鼎國際股份有限公司

Company Representative 公司代表人： Richard Lee 李鐘亮

Company Representative Title 公司代表人職稱： CEO 執行長

Date 日期： 2014 / 07 / 29

(Company Stamp/公司大小章)

Certificate

Issue Date: December 18, 2013
Ref. Report No. ISL-13HE356CE

Product Name	:	SATA Slim 3SE／SATA Slim 3SE-P
Model(s)	:	DESLM-XXXD06*#%※&; DESLM-XXXD67*#%※&
Responsible Party	:	Innodisk Corporation
Address	:	9F, No. 100, Sec. 1 Xintai 5th Rd., Xizhi City, Taipei 221, Taiwan

We, **International Standards Laboratory**, hereby certify that:

The device bearing the trade name and model specified above has been shown to comply with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in European Council Directive- EMC Directive 2004/108/EC. The device was passed the test performed according to :

CE

Standards:

EN 55022: 2010 and CISPR 22: 2008 (modified)
EN 61000-3-2: 2006+A1:2009 +A2:2009 and IEC 61000-3-2: 2005+A1:2008 +A2:2009
EN 61000-3-3: 2008 and IEC 61000-3-3: 2008
EN 55024: 2010 and CISPR 24: 2010
EN 61000-4-2: 2009 and IEC 61000-4-2: 2008
EN 61000-4-3: 2006+A1: 2008 +A2: 2010 and
IEC 61000-4-3:2006+A1: 2007+A2: 2010
EN 61000-4-4: 2004 +A1:2010 and IEC 61000-4-4: 2004 +A1:2010

I attest to the accuracy of data and all measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

International Standards Laboratory

Jim Chu / Director

☒ **Hsi-Chih LAB**:
No. 65, Gu Dai Keng St., Hsichih District,
New Taipei City 22179, Taiwan
Tel: 886-2-2646-2550; Fax: 886-2-2646-4641

Nemko
ELA113A

Certificate

Issue Date: December 18, 2013
Ref. Report No. ISL-13HE356FB

Product Name	:	SATA Slim 3SE／SATA Slim 3SE-P
Model(s)	:	DESLM-XXXD06*#%※&; DESLM-XXXD67*#%※&
Applicant	:	Innodisk Corporation
Address	:	9F, No. 100, Sec. 1 Xintai 5th Rd., Xizhi City, Taipei 221, Taiwan

We, International Standards Laboratory, hereby certify that:

The device bearing the trade name and model specified above has been shown to comply with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified. (refer to Test Report if any modifications were made for compliance).

Standards:

FCC CFR Title 47 Part 15 Subpart B: 2010- Section 15.107 and 15.109
ANSI C63.4-2009
Industry Canada Interference-Causing Equipment Standard ICES-003 Issue 5: 2012

Class B

I attest to the accuracy of data and all measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

International Standards Laboratory

Jim Chu / Director

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